



Edition 2.0 2010-08

INTERNATIONAL STANDARD

NORME INTERNATIONALE

Connecting devices eFlat quick-connect terminations for electrical copper conductors – Safety requirements (Standards.iteh.ai)

Dispositifs de connexion – Bornes plates à connexion rapide pour conducteurs électriques en cuivre – Exigences de sécurité

9bf119b4022b/iec-61210-2010





THIS PUBLICATION IS COPYRIGHT PROTECTED

Copyright © 2010 IEC, Geneva, Switzerland

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from either IEC or IEC's member National Committee in the country of the requester.

If you have any questions about IEC copyright or have an enquiry about obtaining additional rights to this publication, please contact the address below or your local IEC member National Committee for further information.

Droits de reproduction réservés. Sauf indication contraire, aucune partie de cette publication ne peut être reproduite ni utilisée sous quelque forme que ce soit et par aucun procédé, électronique ou mécanique, y compris la photocopie et les microfilms, sans l'accord écrit de la CEI ou du Comité national de la CEI du pays du demandeur. Si vous avez des questions sur le copyright de la CEI ou si vous désirez obtenir des droits supplémentaires sur cette publication, utilisez les coordonnées ci-après ou contactez le Comité national de la CEI de votre pays de résidence.

IEC Central Office 3, rue de Varembé CH-1211 Geneva 20 Switzerland Email: inmail@iec.ch Web: www.iec.ch

About the IEC

The International Electrotechnical Commission (IEC) is the leading global organization that prepares and publishes International Standards for all electrical, electronic and related technologies.

About IEC publications

The technical content of IEC publications is kept under constant review by the IEC. Please make sure that you have the latest edition, a corrigenda or an amendment might have been published.

Catalogue of IEC publications: www.iec.ch/searchpub ARD PREVIEW

The IEC on-line Catalogue enables you to search by a variety of criteria (reference number, text, technical committee,...). It also gives information on projects, withdrawn and replaced publications.

IEC Just Published: www.iec.ch/online news/justpub
Stay up to date on all new IEC publications. Just Published details twice a month all new publications released. Available on-line and also by email.

• Electropedia: <u>www.electropedia.org.ds.iteh.ai/catalog/standards/sist/2502bca1-3273-4ba7-875d-</u> The world's leading online dictionary of electronic and electrical terms containing more than 20 000 terms and definitions in English and French, with equivalent terms in additional languages. Also known as the International Electrotechnical Vocabulary online.

Customer Service Centre: <u>www.iec.ch/webstore/custserv</u>

If you wish to give us your feedback on this publication or need further assistance, please visit the Customer Service Centre FAQ or contact us:

Email: <u>csc@iec.ch</u> Tel.: +41 22 919 02 11 Fax: +41 22 919 03 00

A propos de la CEI

La Commission Electrotechnique Internationale (CEI) est la première organisation mondiale qui élabore et publie des normes internationales pour tout ce qui a trait à l'électricité, à l'électronique et aux technologies apparentées.

A propos des publications CEI

Le contenu technique des publications de la CEI est constamment revu. Veuillez vous assurer que vous possédez l'édition la plus récente, un corrigendum ou amendement peut avoir été publié.

Catalogue des publications de la CEI: www.iec.ch/searchpub/cur_fut-f.htm

Le Catalogue en-ligne de la CEI vous permet d'effectuer des recherches en utilisant différents critères (numéro de référence, texte, comité d'études,...). Il donne aussi des informations sur les projets et les publications retirées ou remplacées.

Just Published CEI: www.iec.ch/online_news/justpub

Restez informé sur les nouvelles publications de la CEI. Just Published détaille deux fois par mois les nouvelles publications parues. Disponible en-ligne et aussi par email.

Electropedia: <u>www.electropedia.org</u>

Le premier dictionnaire en ligne au monde de termes électroniques et électriques. Il contient plus de 20 000 termes et définitions en anglais et en français, ainsi que les termes équivalents dans les langues additionnelles. Egalement appelé Vocabulaire Electrotechnique International en ligne.

Service Clients: <u>www.iec.ch/webstore/custserv/custserv_entry-f.htm</u>

Si vous désirez nous donner des commentaires sur cette publication ou si vous avez des questions, visitez le FAQ du Service clients ou contactez-nous:

Email: <u>csc@iec.ch</u> Tél.: +41 22 919 02 11

Fax: +41 22 919 03 00





Edition 2.0 2010-08

INTERNATIONAL STANDARD

NORME INTERNATIONALE

Connecting devices eFlasquick connect terminations for electrical copper conductors – Safety requirements ards.iteh.ai)

Dispositifs de connexion – Bornes <u>Eplates à c</u>onnexion rapide pour conducteurs électriques en cuivre de Exigences de sécurité 02bca1-3273-4ba7-875d-9bf119b4022b/iec-61210-2010

INTERNATIONAL ELECTROTECHNICAL COMMISSION

COMMISSION ELECTROTECHNIQUE INTERNATIONALE

PRICE CODE CODE PRIX



ICS 29.120.20

ISBN 978-2-88912-173-1

| FOF | DREWORD | 4 |
|------|---|----|
| 1 | Scope | 6 |
| 2 | Normative references | 6 |
| 3 | Terms and definitions | 7 |
| 4 | Main characteristics | 7 |
| 5 | Marking and information | 8 |
| 6 | Constructional requirements | 8 |
| 7 | General notes for tests | 10 |
| 8 | Type tests | 11 |
| | 8.1 Insertion and withdrawal force | 11 |
| | 8.2 Mechanical overload force (for integral tabs or female connectors) | 11 |
| | 8.3 Temperature rise | |
| | 8.4 Current loading cyclic | 12 |
| | 8.5 Elevated temperature test | |
| | 8.6 Tensile strength test for crimped connections | 13 |
| | nnex A (informative) Maximum permissible temperature (maximum service mperature) | 23 |
| | nnex B (informative) Force gauge for testing flat quick-connect female connec | |
| | nnex C (informative) Female test connectors for testing with integral tabs | |
| | nnex D (informative) Tables showing approximate relationships between mm a | |
| inch | ches or cross-sectional areas in mm ² and AWG sizes as used in North Americ | a |
| allo | ches or cross-sectional areas in mm ² and AWG sizes as used in North Americ lowing to use this standard <u>IEC 61210:2010</u> https://standards.iteh.ai/catalog/standards/sist/2502bca1-3273-4ba7-875d- nnex E (informative) Information relating to cross section of conductors and mensions of male tabs | |
| Ann | nnex E (informative) Information relating to cross section of conductors and | 26 |
| am | | |
| Fiai | gure 1 – Dimensions of male tabs | 18 |
| - | gure 2 – Dimensions of round dimple detents (see Figure 1) | |
| - | gure 3 – Dimensions of rectangular dimple detents (see Figure 1) | |
| • | gure 4 – Dimensions of hole detents (see Figure 1) | |
| | | |
| | gure 5 – Dimensions of female connectors | |
| Ŭ | gure 6 – Double-ended tab | |
| Ŭ | gure 7 – Location of thermocouples | |
| | gure 8 – Connections for electrical tests | |
| | gure B.1 – Force gauge fixture | |
| Figu | gure B.2 – Fixture adjustment | 25 |
| Figu | gure B.3 – Fixture test tab centering | 26 |
| Figu | gure B.4 – In-line and lateral female connectors | 27 |
| Figu | gure B.5 – Fixtureing alignment | 28 |
| Figu | gure C.1 – Dimensions of female connectors | 29 |
| Figu | gure C.2 – Dimensions of female connectors, alternative design | 30 |
| | | |

| Table 1 – Dimensions of male tabs in millimetres | 14 |
|--|----|
| Table 2 – Dimensions of female connectors | 15 |

| Table 3 – Test sequences and sets of samples | 15 |
|--|----|
| Table 4 – Tolerances of test tab thickness | 15 |
| Table 5 – Insertion and withdrawal forces | 16 |
| Table 6 – Retention force | 16 |
| Table 7 – Test current for temperature rise | 16 |
| Table 8 – Test current for current loading, cyclic | 16 |
| Table 9 – Pull force for testing the crimped connection | 17 |
| Table A.1 – Maximum permissible temperature (maximum service temperature) | 23 |
| Table C.1 – Dimensions of female connectors in millimetres (see Figure C.1) | 29 |
| Table C.2 – Dimensions of female connectors in inches (see Figure C.1) | 30 |
| Table C.3 – Dimensions of alternative design female connectors in millimetres (see Figure C.2) | 30 |
| Table C.4 – Dimensions of alternative design female connectors in inches (see Figure C.2) | 31 |
| Table D.1 – Relationship between mm and inches or mm ² and AWG within the scope | 32 |
| Table D.2 Relationship between mm and inches in Subclause 4.1 | 32 |
| Table D.3 – Approximate relationship between cross-sectional area in mm ² and AWG sizes in Subclause 4.2 | 32 |
| Table D.4 – Dimensions of male tabs in inches applicable in Subclauses 6.3 and 8.1 (equivalent with Table 1). | 33 |
| Table D.5 – Dimensions of female connectors applicable in Subclause 6.4 (equivalent with Table 2) | 34 |
| Table D.6 – Tolerances of test tab thickness Table D.6 – Tolerances of test tab thickness with Table 4) https://standards.itch.ai/catalog/standards/sist/2502bca1-3273-4ba7-875d | 34 |
| Table D.7 – Insertion and withdrawallforces applicable in Subclause 8.1 (equivalent with Table 5) | 34 |
| Table D.8 – Retention force applicable in Subclause 8.2 (equivalent with Table 6) | 34 |
| Table D.9 – Test current for temperature rise applicable in Subclauses 8.3 and 8.5(equivalent with Table 7) | 35 |
| Table D.10 – Test current for current loading, cyclic applicable in Subclause 8.4 (equivalent with Table 8) | 35 |
| Table D.11 – Pull force for testing the crimped connection applicable in Subclause 8.6 (equivalent with Table 9) | 35 |
| Table E.1 – Relationships between conductors and tabs | 36 |

INTERNATIONAL ELECTROTECHNICAL COMMISSION

CONNECTING DEVICES – FLAT QUICK-CONNECT TERMINATIONS FOR ELECTRICAL COPPER CONDUCTORS – SAFETY REQUIREMENTS

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committee; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- The formal decisions or agreements of IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested IEC National Committees.
- 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.
- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
- https://standards.iteh.ai/catalog/standards/sist/2502bca1-3273-4ba7-875d 5) IEC itself does not provide any attestation of conformity. Independent certification bodies provide conformity assessment services and, in some areas, access to IEC marks of conformity. IEC is not responsible for any services carried out by independent certification bodies.
- 6) All users should ensure that they have the latest edition of this publication.
- 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC Publications.
- 8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.
- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

International Standard IEC 61210 has been prepared by subcommittee 23F: Connecting devices, of IEC technical committee 23: Electrical accessories.

This second edition cancels and replaces the first edition published in 1993 and constitutes a merge between the first edition of IEC 61210 published by SC23F and IEC 60760 published in 1989 by SC48B. This second edition does not introduce major technical modifications.

The text of this standard is based on the following documents:

| FDIS | Report on voting |
|--------------|------------------|
| 23F/200/FDIS | 23F/202/RVD |

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

iTeh STANDARD PREVIEW (standards.iteh.ai)

<u>IEC 61210:2010</u> https://standards.iteh.ai/catalog/standards/sist/2502bca1-3273-4ba7-875d-9bf119b4022b/iec-61210-2010

CONNECTING DEVICES – FLAT QUICK-CONNECT TERMINATIONS FOR ELECTRICAL COPPER CONDUCTORS – SAFETY REQUIREMENTS

1 Scope

This International Standard applies to non-insulated flat quick-connect terminations consisting of a male tab of size 2,8 mm, 4,8 mm, 6,3 mm or 9,5 mm with hole or dimple detents and a mating female connector for use as either an incorporated or an integrated part of an equipment or of a component, or as a separate entity. This standard establishes uniform requirements for the dimensions, performance characteristics and test program.

The connected electrical copper conductors shall be flexible or rigid stranded, having a cross-sectional area up to and including 6 mm² or rigid solid having a cross-sectional area up to and including 2,5 mm². This standard shall not be used for connecting aluminum conductors.

The rated voltage shall not exceed 1 000 V a.c. with a frequency up to and including 1 000 Hz, and 1 500 V d.c., and having the temperature limits applicable to materials used within this standard.

iTeh STANDARD PREVIEW

NOTE 1 This standard, where applicable, may be used for conductors made of material other than copper.

IEC 61210

NOTE 2 For reasons of safety, it is recommended that flat quick-connect terminations beyond the scope of this standard should not be interchangeable with those of this standard.

NOTE 3 This standard does not apply to female connectors with positive locking means 5d-

NOTE 4 The flat quick-connect terminations covered by this standard are not intended to be disconnected by pulling on the cable.

NOTE 5 Annex D provides additional information on non international units.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60068-1:1988, Environmental testing – Part 1: General and guidance

IEC 60352-2:2006, Solderless connections – Part 2: Crimped connections – General requirements, test methods and practical guidance

ISO 1456:2009, Metallic and other inorganic coatings – Electrodeposited coatings of nickel, nickel plus chromium, copper plus nickel and of copper plus nickel plus chromium

ISO 2081:2008, Metallic and other inorganic coatings – Electroplated coatings of zinc with supplementary treatments on iron or steel

ISO 2093:1986, *Electroplated coatings of tin – Specification and test methods*

Terms and definitions 3

For the purpose of this document the following terms and definitions apply:

3.1

flat quick-connect termination

electrical connection consisting of a male tab and a female connector which can be inserted and withdrawn with or without the use of a tool

3.2

male tab

that portion of a flat quick-connect termination which receives the female connector

3.3

male test tab

male tab manufactured with tighter tolerances for the specific purpose of conducting mechanical tests with production female connectors

3.4

female connector

that portion of a flat quick-connect termination which is pushed onto the male tab

3.5 detent

detent dimple (depression) or hole in the male tab which engages a raised portion on the female connector to provide a latch for the mating parts siteh.ai)

3.6

maximum permissible temperature https://standards.jteh.a/catalog/standards/sist/2502bca1-3273-4ba7-875d-IEC 61210:2010 maximum service temperature highest temperature which the flat quick-connect termination is allowed to attain in normal use

Main characteristics 4

4.1 Flat guick-connect terminations are classified into sizes according to the nominal width and thickness of the male tabs. This standard covers the following nominal sizes:

- 2,8 mm \times 0,5 mm
- 2,8 mm × 0,8 mm
- 4,8 mm \times 0,5 mm
- 4,8 mm × 0,8 mm
- 6,3 mm × 0,8 mm
- 9,5 mm × 1,2 mm

NOTE Relationship between millimetres and inches is shown in Table D.2.

4.2 The preferred conductor cross-sectional areas shall be 0,2 mm², 0,34 mm², 0,5 mm², 0,75 mm², 1,0 mm², 1,5 mm², 2,5 mm², 4,0 mm² and 6,0 mm².

NOTE The approximate equivalent relationship between cross-sectional area in mm² and AWG sizes is shown in Table D.3.

5 Marking and information

5.1 The manufacturer of male tabs and/or female connectors supplied separately and the manufacturer of the component with integral tabs and/or female connectors shall provide adequate information to ensure that the flat quick-connect termination can be applied in the intended manner and that the testing authority can perform the relevant tests in accordance with this standard.

- **5.2** This information shall be provided in the following methods, as detailed in 5.3:
 - by marking (Ma)

The information shall be clearly and indelibly marked on the male tab and on the female connector.

NOTE In the case of integral tabs (e.g. in switches for appliances) the marking may be located on the switch itself.

by documentation (Do)

The information shall be provided by a separate document, which may consist of a leaflet, label or a specification sheet, supplied with the smallest package unit or supplied separately. The content of the document shall be available to the end user or to the component or equipment manufacturer and to the testing authority, as appropriate, in any suitable format. The format in which this information is presented is not within the scope of this standard. ARD PREVIEW

by declaration (De)

(standards.iteh.ai)

This information shall be provided to the testing authority for the purpose of testing and in a manner agreed between the testing authority and the manufacturer.

https://standards.iteh.ai/catalog/standards/sist/2502bca1-3273-4ba7-875d-

- 5.3 The following information shall be supplied by the methods indicated.
 - a) Manufacturer's name or trade mark Ma (see note 1)
 - b) Type reference..... Do (see note 2)
 - c) Nominal series designation (size: width and thickness, see 4.1).. Do (see note 2)
 - d) Maximum permissible temperature if higher than 85 °C..... Do (see note 3)

 - f) Type of conductor(s) for which that part of the termination is suitable......Do
 - g) Conductor cross-sectional area for which that part of the termination is suitableDo
 - h) The recommended method of attaching the conductor to the termination (i.e. tool, stripping length, any special preparation, etc.)Do
 - i) The material(s) and type of coatingDe

NOTE 1 The information for integrated tabs or female connectors may be given together with the equipment or component.

NOTE 2 An appropriate code may be used for this information.

NOTE 3 The insulation of the cable and of the contact-carrying plastic parts should be compatible with the declared maximum permissible temperature.

NOTE 4 In Japan, tab thickness marking on the female connector is 5 for 0,5 mm and 8 for 0,8 mm.

6 Constructional requirements

6.1 Flat quick-connect terminations shall be so designed and constructed that in normal use their performance is reliable and without danger to the user or surroundings.

Compliance is checked by the tests of 8.1 to 8.6.

6.2 Male tabs and female connectors shall be of a metal having mechanical strength, electrical conductivity and resistance to corrosion adequate for their intended use.

Compliance is checked by inspection, by the tests of 8.1 to 8.6 and, if necessary, by chemical analysis.

Examples of suitable metals, when used within the permissible temperature range and under standard atmospheric conditions, are

- copper (for tabs only);
- an alloy containing at least 58 % copper for parts made from rolled sheet (in cold condition) or at least 50 % copper for other parts;
- stainless steel containing at least 13 % chromium and not more than 0,09 % carbon;
- steel provided with an electroplated coating of zinc (for earthing conductors only), according to ISO 2081;
- steel provided with an electroplated coating of nickel, according to ISO 1456;
- steel provided with an electroplated coating of tin, according to ISO 2093.

NOTE The choice of material and coating is left to the relevant product committees who should consider the pollution conditions occurring in the equipment or component where the flat quick-connect termination is mounted.

6.3 The dimensions of male tabs shall comply with those specified in Table 1 and Figures 1, 2, 3 and 4 where the dimensions *A*, *B*, *C*, *D*, *E*, *F*, *J*, *M*, *N* and *Q* are mandatory.

NOTE 1 The shapes of the various parts may deviate from those given in the figures, provided that the specified dimensions are not influenced and the test requirements are local table, for example: corrugated table, folded table, etc. https://standards.iteh.ai/catalog/standards/sist/2502bca1-3273-4ba7-875d-

NOTE 2 Dimensions of male tabs in inches are shown in Table D.4.

Compliance is checked by inspection and measurement.

6.4 The dimensions of female connectors shall comply with those specified in Table 2 and Figure 5 where L_2 , B_3 and 1,5 mm maximum are mandatory.

NOTE Dimensions of female connectors for tab size in inches are shown in Table D.5.

Compliance is checked by inspection and measurement.

6.5 Male tabs and female connectors shall be so designed and constructed as to allow the correct insertion and withdrawal of either the female connector or the tab without damage or loosening of other components.

Compliance is checked by the insertion and withdrawal force test of 8.1.

6.6 Male tabs and female connectors integral with equipment or components shall be securely retained.

Compliance is checked by the mechanical overload force test of 8.2.

6.7 Male tabs and female connectors shall be so designed and constructed that the temperature rise in normal use does not reach values likely to impair their further use.

Compliance is checked by the temperature rise test of 8.3.

6.8 Male tabs and female connectors shall be so designed and constructed that their electrical performances are reliable and their further use is not impaired.

Compliance is checked by the cyclic current loading test of 8.4.

6.9 Male tabs and female connectors having a maximum permissible temperature higher than 85 °C shall be so designed and constructed that in normal use their electrical performances are reliable and their further use is not impaired.

Compliance is checked by the elevated temperature test of 8.5.

Examples of maximum permissible temperatures of male tabs and female connectors, depending on materials and/or coating, are given as a guide in Annex A.

6.10 Crimped connections shall be such that they withstand the mechanical stresses likely to occur in normal use.

Compliance is checked by the tensile strength test of 8.6.

6.11 Male tabs and female connectors for solid conductors shall be so designed and constructed that any disturbance does not affect the crimped connection and their further use is not impaired.

Compliance is checked by the tests in 6.5 to 6 RD PREVIEW

(standards.iteh.ai)

7 General notes for tests

IEC 61210:2010

7.1 Tests according to sthis standard are type tests t/2502bca1-3273-4ba7-875d-

9bf119b4022b/iec-61210-2010

7.2 Unless otherwise specified, the samples shall be tested as delivered and connected as for normal use, at an ambient temperature of 20 °C \pm 5 °C.

7.3 Unless otherwise specified, all tests shall be carried out under standard atmospheric conditions for testing as specified in IEC 60068-1.

7.4 Test specimens shall be preconditioned under standard atmospheric conditions for testing for a time sufficient to allow the entire component to reach thermal stability.

7.5 Temperature rise and cyclic current loading tests shall be conducted in still air, i.e. airflow less than 10 m/min at room temperature.

7.6 If samples are not delivered with conductors already assembled, the conductors shall be connected to the associated parts in accordance with the manufacturer's instructions and using the manufacturer's recommended tooling. If no specific manufacturer's instructions are provided, then refer to IEC 60352-2 for proper assembly instructions.

7.7 The tests shall be carried out on each set in the sequence as specified in Table 3, according to the most onerous combination of the tab and female connector according to item e) of 5.3.

7.8 Testing for integral tabs (see item D of Table 3) shall be performed using the test connectors in Annex C.

8 Type tests

8.1 Insertion and withdrawal force

Ten male test tabs and ten female connectors are required. The male tabs shall be special male test tabs manufactured to close tolerances for the specific purpose of conducting this test.

Male test tabs shall be of half-hard brass, having a hardness of (62 ± 7) HR30T and shall conform to Figures 1, 2, 3 and 4 and Table 1, except that the *C* dimension tolerance shall be as indicated in Table 4, and any raised plateau around the detent shall be limited to a total of 0,025 mm over the stock thickness (see Figure 1).

NOTE 1 Tolerances of nominal test tab thickness expressed in inches are shown in Table D.6.

The male test tabs shall not be coated.

NOTE 2 A male tab from the production line that complies with the dimensions for test tabs may also be suitable.

A new male test tab shall be used for each female connector tested. For each combination of male tab and female connector, the tab shall be slowly and steadily inserted and withdrawn six times at a rate of travel of approximately 1 mm/s.

Insertion and withdrawal force measurements shall be made with any suitable testing device providing accurate alignment and being capable of holding the reading. An example of a suitable device is shown in Annex B. (standards.iteh.ai)

Compliance is checked as follows:

IEC 61210:2010

The insertion and withdrawar forces shall be within the limits as specified in Table 5.

NOTE 3 The insertion and withdrawal forces for sizes expressed in AWG are shown in Table D.7.

8.2 Mechanical overload force (for integral tabs or female connectors)

An axial force, equal to that shown in Table 6, is applied smoothly once only with a suitable test apparatus for a period of 1 min. No damage which could impair further use shall occur to the tab or to the female connector or to the equipment in which the tab is integrated.

NOTE Retention force for sizes expressed in inches is shown in Table D.8.

Compliance is checked by inspection after completion of the test.

8.3 Temperature rise

The temperature rise test shall be conducted using six double ended male test tabs (see Figure 6) and twelve female connectors connected to conductors of the same type and of the largest cross-sectional area.

The test tab material shall be

- uncoated half-hard brass having a hardness of (62 ± 7) HR30T for female connectors made from copper alloy (coated or bare);
- nickel coated steel for female connectors made of nickel coated steel or stainless steel.

The test shall be carried out with male tabs and female connectors as delivered. In no case shall the test samples be cleaned or otherwise prepared prior to test, unless explicitly required by the documentation.

Crimp terminations shall be crimped within 1 h after the removal of the insulation from the associated conductors. The terminations shall be crimped with an appropriate crimping tool which has been adjusted in accordance with the manufacturer's instructions.

All test samples are subjected to visual examination and dimensional measurement prior to connecting the conductor.

Test samples shall be connected on each end of 178 mm length of uncoated insulated copper conductors. The insulation of the conductor shall be as specified by the flat quick-connect termination manufacturer.

The test samples shall be fitted with fine wire thermocouples placed in such a way so as not to influence the contact or the connection area of the test sample. An example of placement is shown in Figure 7. A thermocouple shall be installed so as to obtain thermal and mechanical bonding with the surface of a connector and without causing an appreciable change in the temperature of the connector, for example by the use of small quantities of an adhesive.

During the test, the samples shall be arranged and connected as shown in Figure 8. The test current as specified in Table 7 is passed through the samples until thermal equilibrium has been established. The temperature of the samples and the ambient temperature are measured and recorded.

NOTE 1 With agreement between the testing facility and the manufacturer, the test current may be increased.

NOTE 2 Test current for temperature rise for sizes expressed in AWG is shown in Table D.9.

Compliance is checked as follows.

The temperature rise of any individual connection shall not exceed 30 K.

https://standards.iteh.a/catalog/standards/sist/2502bca1-3273-4ba7-875d-9bf119b4022b/iec-61210-2010

8.4 Current loading cyclic

The test shall be carried out on the samples already subjected to the temperature rise test of 8.3.

Cross-sectional areas, insulation of conductors and the test arrangement shall be as for 8.3. The twelve samples are subjected to 500 cycles. Each cycle consists of 45 min under the overload test current as specified in Table 8 and 15 min without current.

NOTE Test current for current loading cyclic for sizes expressed in AWG is shown in Table D.10.

Compliance is checked as follows:

The temperature rise Δt_1 of any individual connection shall be measured after the 24th cycle and the temperature rise Δt_2 of any individual connection shall be measured after the 500th cycle. The Δt_2 value shall not exceed the Δt_1 value by more than 15 K. Neither individual temperature rise, Δt_1 or Δt_2 , shall exceed 85 K.

8.5 Elevated temperature test

The test shall be performed in a heating cabinet at the declared maximum permissible temperature, decreased by 45 K, on samples having a maximum permissible temperature higher than 85 $^{\circ}$ C and already subjected to the tests of 8.3 and 8.4.

Cross-sectional areas, insulation of conductors and the test arrangement shall be as specified in 8.3.

Care shall be taken not to disturb the samples, the conductors or the test arrangement when placing them in the heating cabinet.

The samples are subjected to eight cycles of elevated temperature. Each cycle consists of 23 h applying the test current as specified in Table 7 and 1 h without current. After the first hour, the temperature of the heating cabinet is adjusted, if necessary, until the average temperature using all the samples under test equals the maximum permissible temperature.

After the last heating cycle, the samples are allowed to cool down to ambient temperature.

Compliance is checked as follows:

The temperature rise test of 8.3 shall be repeated using the current from Table 7, and the temperature rise for any connector shall not exceed 45 K.

NOTE Test current for temperature rise for sizes expressed in AWG is shown in Table D.9.

8.6 Tensile strength test for crimped connections

The test shall be conducted on 10 new samples, with any wire insulation support rendered mechanically ineffective.

The conductor shall be assembled to the connector using the manufacturer's instructions and with the specified crimping tool STANDARD PREVIEW

All declared cross-sectional areas of conductors shall be tested.

Additionally, when a combination of two <u>pr more conductors</u> is declared, each conductor shall be tested individually,//in_turn.ieand.ain_accordance_2with_the_2pull_force_dvalue of its cross-sectional area. 9bf119b4022b/iec-61210-2010

The pull force as specified in Table 9 shall be applied for 1 min without jerks, or applied with a tensile machine with the head traveling at a speed of between 25 mm and 50 mm per min.

Compliance is checked as follows:

The force required to separate the crimping area from its attached conductor shall not be less than the pull force of Table 9.

NOTE 1 Tensile strength values for other methods of connection of the conductor are under consideration.

NOTE 2 For conductor connection means other than crimping, a special test may be agreed upon between manufacturers and testing stations.

NOTE 3 The pull force for sizes expressed in AWG is shown in Table D.11.